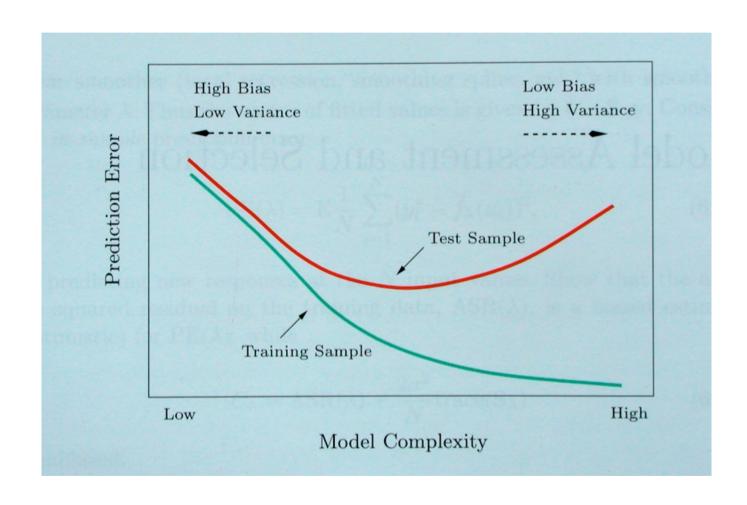
Lecture 4: Ensemble Learning

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Recap

- Decision trees
- Underfitting and overfitting
- Cross validation

Bias/Variance Tradeoff



Bias, Variance and Noise

Variance: Captures how much your classifier changes if you train on a different training set. How "over-specialized" is your classifier to a particular training set (overfitting)? If we have the best possible model for our training data, how far off are we from the average classifier?

Bias: What is the inherent error that you obtain from your classifier even with infinite training data? This is due to your classifier being "biased" to a particular kind of solution (e.g. linear classifier). In other words, bias is inherent to your model.

Noise: How big is the data-intrinsic noise? This error measures ambiguity due to your data distribution and feature representation. You can never beat this, it is an aspect of the data.

Bias and Variance Decomposition

$$\mathbb{B}\mathrm{ias}(\widehat{X}) := \mathbb{E}(\widehat{X}) - X$$

$$\operatorname{Var}(\widehat{X}) := \mathbb{E}((\widehat{X} - \mathbb{E}(\widehat{X}))^2)$$

$$\begin{split} \mathbb{V}\mathrm{ar}(\widehat{X}) &= \mathbb{E}\big(\widehat{X}^2 + (\mathbb{E}(\widehat{X}))^2 - 2\widehat{X}\mathbb{E}(\widehat{X})\big) \\ &\stackrel{(a)}{=} \mathbb{E}(\widehat{X}^2) + (\mathbb{E}(\widehat{X}))^2 - 2\mathbb{E}(\widehat{X})\mathbb{E}(\widehat{X}) \\ &= \mathbb{E}(\widehat{X}^2) - (\mathbb{E}(\widehat{X}))^2, \end{split}$$

Mean square error:

$$\begin{aligned} \operatorname{MSE}(\widehat{X}) &:= \mathbb{E}\big((\widehat{X} - X)^2\big) \\ \operatorname{MSE}(\widehat{X}) &= \mathbb{E}\big((\widehat{X} - X)^2\big) \\ &= \mathbb{E}\big((\widehat{X} - \mathbb{E}(\widehat{X}) + \mathbb{E}(\widehat{X}) - X)^2\big) \\ &= \mathbb{E}\big((\widehat{X} - \mathbb{E}(\widehat{X}))^2 + (\mathbb{E}(\widehat{X}) - X)^2\big) \\ &= \mathbb{E}\big((\widehat{X} - \mathbb{E}(\widehat{X}))^2 + (\mathbb{E}(\widehat{X}) - X)^2\big) \\ &+ 2(\widehat{X} - \mathbb{E}(\widehat{X}))(\mathbb{E}(\widehat{X}) - X)\big) \\ \stackrel{(a)}{=} \mathbb{E}\big((\widehat{X} - \mathbb{E}(\widehat{X}))^2\big) + (\mathbb{E}(\widehat{X}) - X)^2 \\ &+ 2\underbrace{(\mathbb{E}(\widehat{X}) - \mathbb{E}(\widehat{X}))}_{0}(\mathbb{E}(\widehat{X}) - X) \end{aligned}$$

$$\stackrel{(b)}{=} \mathbb{V}\operatorname{ar}(\widehat{X}) + (\mathbb{B}\operatorname{ias}(\widehat{X}))^2,$$

Bias and Variance Decomposition

$$\underbrace{E_{\mathbf{x},y,D}\left[\left(h_D(\mathbf{x})-y\right)^2\right]}_{\text{Expected Test Error}} = \underbrace{E_{\mathbf{x},D}\left[\left(h_D(\mathbf{x})-\bar{h}(\mathbf{x})\right)^2\right]}_{\text{Variance}} + \underbrace{E_{\mathbf{x},y}\left[\left(\bar{y}(\mathbf{x})-y\right)^2\right]}_{\text{Noise}} + \underbrace{E_{\mathbf{x}}\left[\left(\bar{h}(\mathbf{x})-\bar{y}(\mathbf{x})\right)^2\right]}_{\text{Bias}^2}$$

Expected Label (given $\mathbf{x} \in \mathbb{R}^d$):

$$ar{y}(\mathbf{x}) = E_{y|\mathbf{x}}\left[Y
ight] = \int\limits_{\mathcal{U}} y \; \mathrm{Pr}(y|\mathbf{x}) \partial y.$$

Expected Test Error (given h_D):

$$E_{(\mathbf{x},y)\sim P}\left[\left(h_D(\mathbf{x})-y
ight)^2
ight]=\iint\limits_x\left(h_D(\mathbf{x})-y
ight)^2\mathrm{Pr}(\mathbf{x},y)\partial y\partial \mathbf{x}.$$

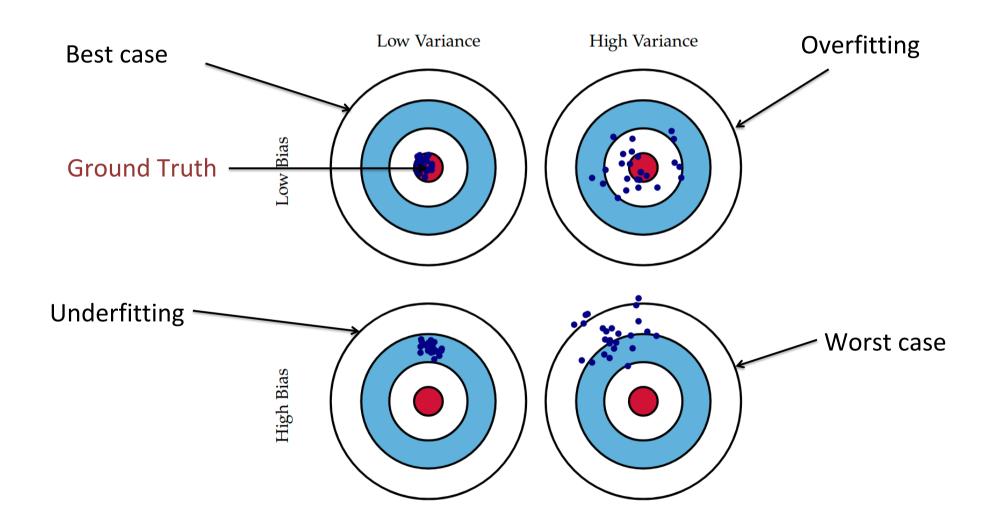
Expected Classifier (given A):

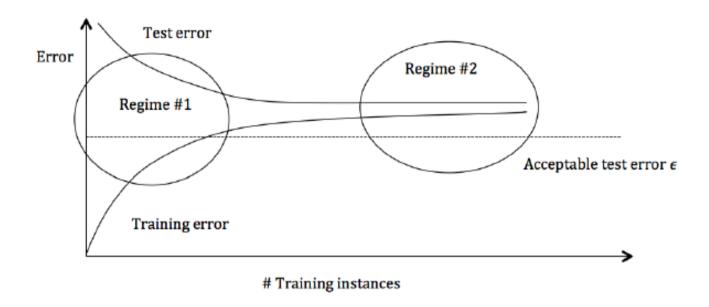
$$ar{h} = E_{D\sim P^n}\left[h_D
ight] = \int h_D \Pr(D) \partial D$$

Expected Test Error (given A):

$$E_{\substack{(\mathbf{x},y)\sim P\\D\sim P^n}}\left[\left(h_D(\mathbf{x})-y\right)^2\right]=\int_D\int_{\mathbf{x}}\int_y\left(h_D(\mathbf{x})-y\right)^2\mathrm{P}(\mathbf{x},y)\mathrm{P}(D)\partial\mathbf{x}\partial y\partial D$$

Bias/Variance Tradeoff





	Regime 1 - High Variance	Regime 2 - High Bias
	Training error is much lower than test error	Training error is lower than epsilon
Symptoms	Training error is lower than epsilon	
	Test error is above epsilon	
Remedy	Add more training data	Add features
	Reduce model complexity complex Models are prone to high variance	Use more complex model (e.g. kernelize, use non-linear models)
	Bagging	Boosting

Questions?

Solve the questionnaire shared. Will be used for attendance.

Ensemble Learning

- Simple learners:
 - Are good- Low variance, don't usually overfit
 - Are bad: High bias, can't solve hard learning problems
- Instead of learning a single (weak) classifier, learn many weak classifiers that are good at different parts of the input space
- How to combine multiple classifiers into a single one
- Works well if the classifiers are complementary
- Two types of ensemble methods:
 - Bagging
 - Boosting

Reduce Variance Without Increasing Bias

Averaging reduces variance:

$$Var(\bar{X}) = \frac{Var(X)}{n}$$
 (when predictions are **independent**)

Average models to reduce model variance

One problem:

only one training set

where do multiple models come from?

Bagging: Bootstrap Aggregation

- Leo Breiman (1994)
- Take repeated bootstrap samples from training set *D*.
- Bootstrap sampling: Given set D containing N training examples, create D' by drawing N examples at random with replacement from D.
- Bagging:
 - Create k bootstrap samples $D_1 \dots D_k$.
 - —Train the classifier on each D_i .
 - Classify new instance by majority vote / average.

Bagging (Bootstrap AGgregatING)

Input: n labelled training examples (x_i, y_i) , i = 1,...,n

Algorithm:

Repeat k times:

Select m samples out of n with replacement to get training set S_i

Train classifier (decision tree, k-NN, perceptron, etc) hi on Si

Output: Classifiers h₁, .., h_k

Classification: On test example x, output majority($h_1, ..., h_k$)

Example

Input: n labelled training examples (x_i, y_i) , i = 1,...,n

Algorithm:

Repeat k times:

Select m samples out of n with replacement to get training set S_i

Train classifier (decision tree, k-NN, perceptron, etc) hi on Si

How to pick m?

Popular choice: m = n

Still different from working with entire training set. Why?

Bagging

Input: n labelled training examples $S = \{(x_i, y_i)\}, i = 1,...,n$

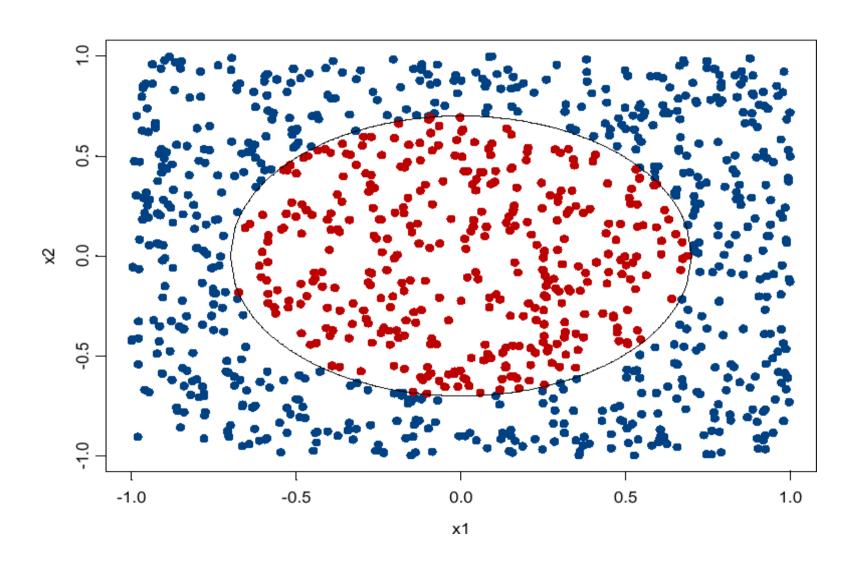
Suppose we select n samples out of n with replacement to get training set S_i

Still different from working with entire training set. Why?

$$\Pr(S_i = S) = \frac{n!}{n^n}$$
 (tiny number, exponentially small in n)
 $\Pr((x_i, y_i) \text{ not in } S_i) = \left(1 - \frac{1}{n}\right)^n \approxeq e^{-1}$

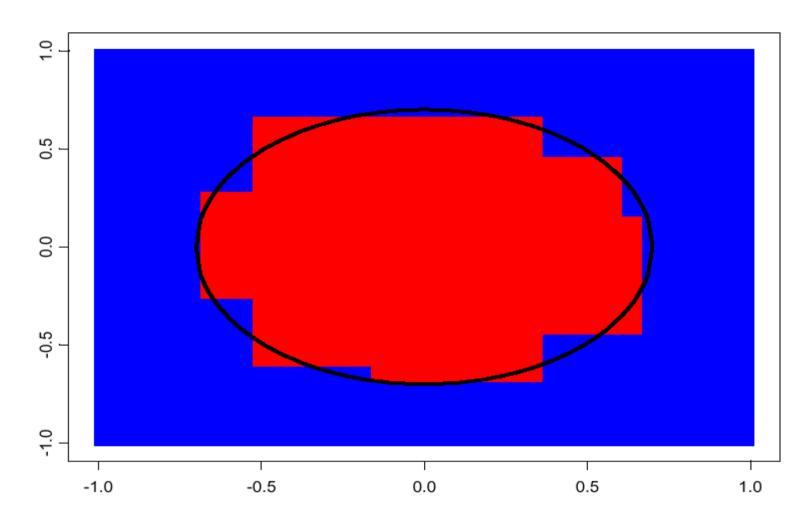
For large data sets, about 37% of the data set is left out!

Example

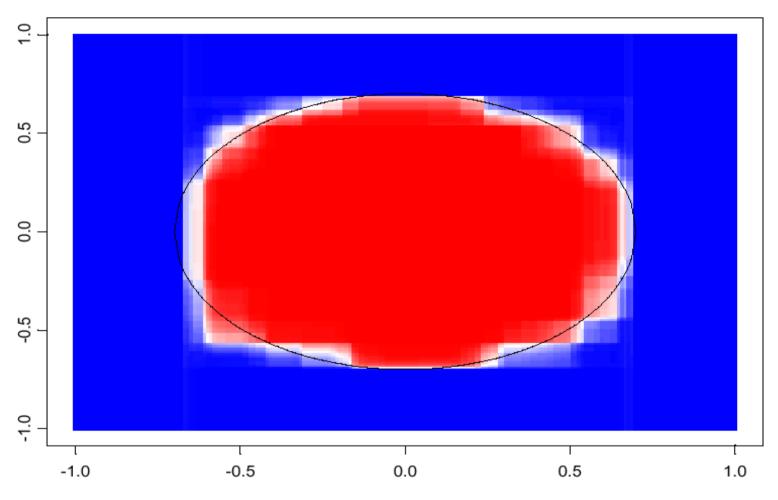


decision tree learning algorithm; very similar to ID3

CART decision boundary

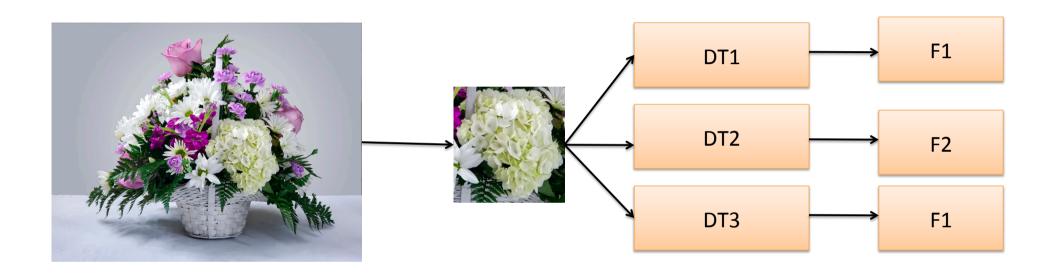


100 bagged trees



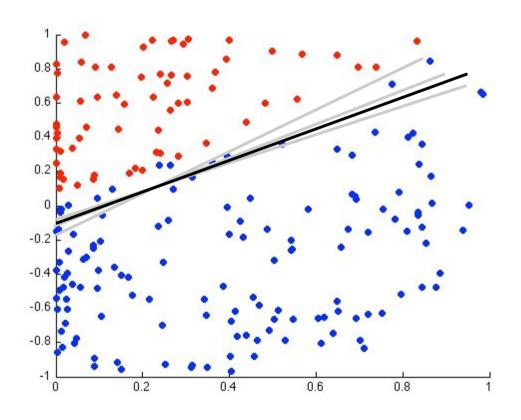
shades of blue/red indicate strength of vote for particular classification

Random Decision Forest



Majority voting: FI

Why is Bagging useful?



Bagging reduces the variance of the classifier, doesn't help much with bias

Questions?

Ensemble Learning

How to combine multiple classifiers into a single one

Works well if the classifiers are complementary

This class: two types of ensemble methods:

Bagging

Boosting

Goal: Determine if an email is spam or not based on text in it

From: Yuncong Chen

Text: 151 homeworks are all graded...

Not Spam

From: Work from home solutions

Text: Earn money without working!

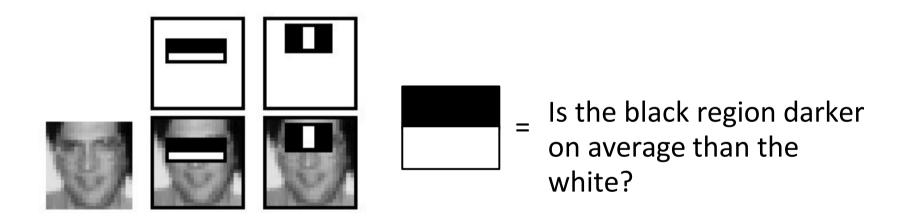
Spa

m

Sometimes it is:

- Easy to come up with simple rules-of-thumb classifiers,
- Hard to come up with a single high accuracy rule

Goal: Detect if an image contains a face in it



Sometimes it is:

- Easy to come up with simple rules-of-thumb classifiers,
- Hard to come up with a single high accuracy rule

Weak Learner: A simple rule-of-the-thumb classifier that doesn't necessarily work very well

Strong Learner: A good classifier

Boosting: How to combine many weak learners into a strong learner?

Procedure:

- 1. Design a method for finding a good rule-of-thumb
- 2. Apply method to training data to get a good rule-of-thumb
- 3. Modify the training data to get a 2nd data set
- 4. Apply method to 2nd data set to get a good rule-of-thumb
- 5. Repeat Ttimes...

- 1. How to get a good rule-of-thumb?

 Depends on application e.g, single node decision trees
- 2. How to choose examples on each round?

Focus on the **hardest examples** so far - namely, examples misclassified most often by previous rules of thumb

3. How to combine the rules-of-thumb to a prediction rule? Take a weighted majority of the rules

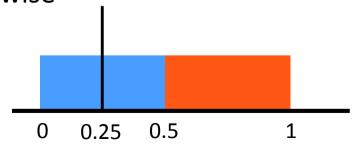
Some Notations

Let D be a distribution over examples, and h be a classifier Error of h with respect to D is:

$$err_D(h) = Pr_{(X,Y) \sim D}(h(X) \neq Y)$$

Example:

Below X is uniform over [0, 1], and Y = 1 if X > 0.5, 0 otherwise



$$err_{D}(h) = 0.25$$

Some Notation

Let D be a distribution over examples, and h be a classifier Error of h with respect to D is:

$$err_D(h) = Pr_{(X,Y) \sim D}(h(X) \neq Y)$$

h is called a **weak learner** if $err_D(h) < 0.5$

If you guess completely randomly, then the error is 0.5

Some Notation

Given training examples $\{(x_i, y_i)\}$, i = 1,...,n, we can assign weights w_i to the examples. If the w_i s sum to 1, then we can think of them as a distribution W over the examples.

The error of a classifier h wrt Wis:

$$err_W(h) = \sum_{i=1}^n w_i 1(h(x_i) \neq y_i)$$

Note: 1 here is the indicator function

Given training set $S = \{(x_1, y_1), ..., (x_n, y_n)\}, y \text{ in } \{-1, 1\}$

For t = I,...,T

Construct distribution D_t on the examples

Find weak learner ht which has small error errot(ht) wrt Dt

Output final classifier

Initially, $D_1(i) = 1/n$, for all i (uniform)

Given Dt and ht:

$$D_{t+1}(i) = \frac{D_t(i)}{Z_t} exp(-\alpha_t y_i h_t(x_i))$$

Weight update rule

where:

$$\alpha_t = \frac{1}{2} \ln \left(\frac{1 - err_{D_t}(h_t)}{err_{D_t}(h_t)} \right)$$

 Z_t = normalization constant

Given training set $S = \{(x_1, y_1), ..., (x_n, y_n)\}, y \text{ in } \{-1, 1\}$

For t = I, ..., T

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 $Z_t = normalization constant$

 $D_{t+1}(i)$ goes down if x_i is classified correctly by h_t , up otherwise High $D_{t+1}(i)$ means hard example

Given training set $S = \{(x_1, y_1), ..., (x_n, y_n)\}, y \text{ in } \{-1, 1\}$

For t = 1, ..., T

Construct distribution D_t on the examples

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 $\alpha_t = \frac{1}{2} \ln \left(\frac{1 - err_{D_t}(h_t)}{err_{D_t}(h_t)} \right)$ Higher if h_t has low error wrt D_t, lower otherwise. >0 if err_{Dt}(h_t) < 0.5

 Z_t = normalization constant

Given training set $S = \{(x_1, y_1), ..., (x_n, y_n)\}, y \text{ in } \{-1, 1\}$

For t = 1, ..., T

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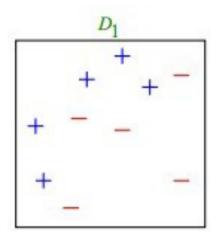
$$D_{t+1}(i) = \frac{D_t(i)}{Z_t} exp(-\alpha_t y_i h_t(x_i))$$

where:

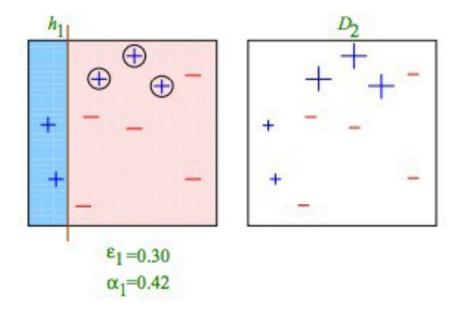
$$\alpha_t = \frac{1}{2} \ln \left(\frac{1 - err_{D_t}(h_t)}{err_{D_t}(h_t)} \right)$$

 $Z_t = normalization constant$

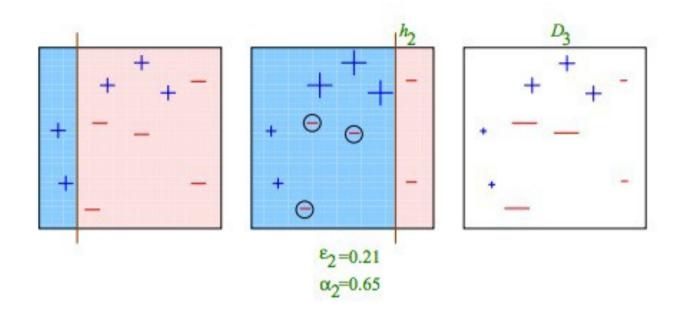
Final
$$sign(\sum_{t=1}^{T} \alpha_t h_t(x))$$



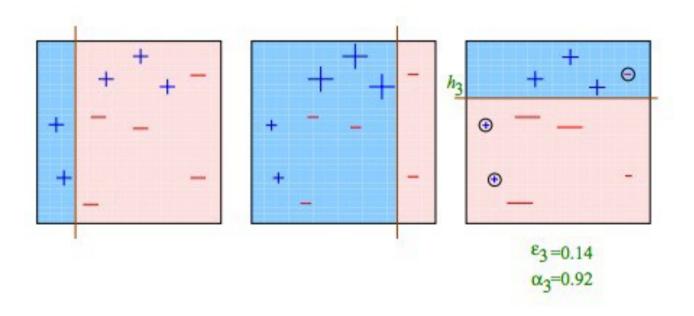
Schapire, 2011



Schapire, 2011

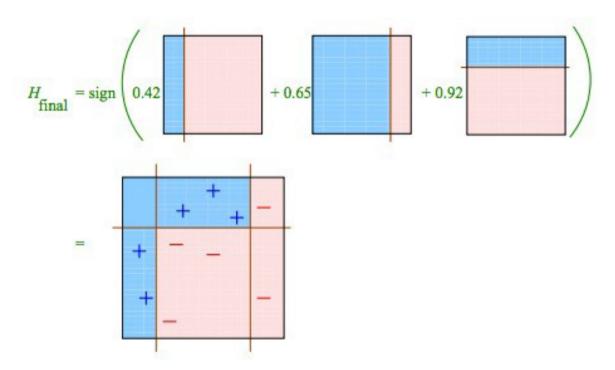


Schapire, 2011



Schapire, 2011

The Final Classifier



Schapire, 2011

How to Find Stopping Time

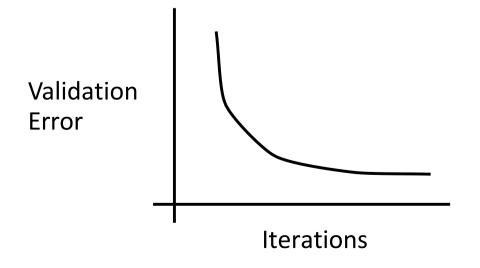
Given training set $S = \{(x_1, y_1), ..., (x_n, y_n)\}, y \text{ in } \{-1, 1\}$

For t = 1, ..., T

Construct distribution D_t on the examples

Find weak learner ht which has small error errot(ht) wrt Dt

Output final classifier



To find stopping time, use a validation dataset.

Stop when the error on the validation dataset stops getting better, or when you can't find a good rule of thumb.

Questions?